



Welcome to [E-XFL.COM](#)

### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### Details

Product Status	Active
Number of LABs/CLBs	37950
Number of Logic Elements/Cells	485760
Total RAM Bits	37969920
Number of I/O	350
Number of Gates	-
Voltage - Supply	0.97V ~ 1.03V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	1156-BBGA, FCBGA
Supplier Device Package	1158-FCBGA (35x35)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc7vx485t-2ffg1158c">https://www.e-xfl.com/product-detail/xilinx/xc7vx485t-2ffg1158c</a>

Table 5:  $V_{IN}$  Maximum Allowed AC Voltage Overshoot and Undershoot for 1.8V HP I/O Banks<sup>(1)(2)</sup>

AC Voltage Overshoot	% of UI @-40°C to 100°C	AC Voltage Undershoot	% of UI @-40°C to 100°C
$V_{CCO} + 0.55$	100	-0.55	100
$V_{CCO} + 0.60$	50.0	-0.60	50.0
$V_{CCO} + 0.65$	50.0	-0.65	50.0
$V_{CCO} + 0.70$	47.0	-0.70	50.0
$V_{CCO} + 0.75$	21.2	-0.75	50.0
$V_{CCO} + 0.80$	9.71	-0.80	50.0
$V_{CCO} + 0.85$	4.51	-0.85	28.4
$V_{CCO} + 0.90$	2.12	-0.90	12.7
$V_{CCO} + 0.95$	1.01	-0.95	5.79

**Notes:**

1. A total of 200 mA per bank should not be exceeded.
2. For UI smaller than 20  $\mu$ s.

Table 6: Typical Quiescent Supply Current

Symbol	Description	Device	Speed Grade			Units
			-3	-2/-2L/-2G	-1	
I <sub>CCINTQ</sub>	Quiescent $V_{CCINT}$ supply current	XC7V585T	1483	1483	1483	mA
		XC7V2000T	N/A	3756	3756	mA
		XC7VX330T	1012	1012	1012	mA
		XC7VX415T	1324	1324	1324	mA
		XC7VX485T	1578	1578	1578	mA
		XC7VX550T	2214	2214	2214	mA
		XC7VX690T	2214	2214	2214	mA
		XC7VX980T	N/A	2580	2580	mA
		XC7VX1140T	N/A	3448	3448	mA
I <sub>CCOQ</sub>	Quiescent $V_{CCO}$ supply current	XC7V585T	1	1	1	mA
		XC7V2000T	N/A	1	1	mA
		XC7VX330T	1	1	1	mA
		XC7VX415T	1	1	1	mA
		XC7VX485T	1	1	1	mA
		XC7VX550T	1	1	1	mA
		XC7VX690T	1	1	1	mA
		XC7VX980T	N/A	1	1	mA
		XC7VX1140T	N/A	1	1	mA

## Power-On/Off Power Supply Sequencing

The recommended power-on sequence is  $V_{CCINT}$ ,  $V_{CCBRAM}$ ,  $V_{CCAUX}$ ,  $V_{CCAUX\_IO}$ , and  $V_{CCO}$  to achieve minimum current draw and ensure that the I/Os are 3-stated at power-on. The recommended power-off sequence is the reverse of the power-on sequence. If  $V_{CCINT}$  and  $V_{CCBRAM}$  have the same recommended voltage levels then both can be powered by the same supply and ramped simultaneously. If  $V_{CCAUX}$ ,  $V_{CCAUX\_IO}$ , and  $V_{CCO}$  have the same recommended voltage levels then they can be powered by the same supply and ramped simultaneously.

For  $V_{CCO}$  voltages of 3.3V in HR I/O banks and configuration bank 0:

- The voltage difference between  $V_{CCO}$  and  $V_{CCAUX}$  must not exceed 2.625V for longer than  $T_{VCCO2VCCAUX}$  for each power-on/off cycle to maintain device reliability levels.
- The  $T_{VCCO2VCCAUX}$  time can be allocated in any percentage between the power-on and power-off ramps.

The recommended power-on sequence to achieve minimum current draw for the GTX/GTH transceivers is  $V_{CCINT}$ ,  $V_{MGTAVCC}$ ,  $V_{MGTAVTT}$  OR  $V_{MGTAVCC}$ ,  $V_{CCINT}$ ,  $V_{MGTAVTT}$ . There is no recommended sequencing for  $V_{MGTAVCAUX}$ . Both  $V_{MGTAVCC}$  and  $V_{CCINT}$  can be ramped simultaneously. The recommended power-off sequence is the reverse of the power-on sequence to achieve minimum current draw.

If these recommended sequences are not met, current drawn from  $V_{MGTAVTT}$  can be higher than specifications during power-up and power-down.

- When  $V_{MGTAVTT}$  is powered before  $V_{MGTAVCC}$  and  $V_{MGTAVTT} - V_{MGTAVCC} > 150$  mV and  $V_{MGTAVCC} < 0.7$ V, the  $V_{MGTAVTT}$  current draw can increase by 460 mA per transceiver during  $V_{MGTAVCC}$  ramp up. The duration of the current draw can be up to  $0.3 \times T_{MGTAVCC}$  (ramp time from GND to 90% of  $V_{MGTAVCC}$ ). The reverse is true for power-down.
- When  $V_{MGTAVTT}$  is powered before  $V_{CCINT}$  and  $V_{MGTAVTT} - V_{CCINT} > 150$  mV and  $V_{CCINT} < 0.7$ V, the  $V_{MGTAVTT}$  current draw can increase by 50 mA per transceiver during  $V_{CCINT}$  ramp up. The duration of the current draw can be up to  $0.3 \times T_{VCCINT}$  (ramp time from GND to 90% of  $V_{CCINT}$ ). The reverse is true for power-down.

**Table 7** shows the minimum current, in addition to  $I_{CCQ}$ , that is required by Virtex-7 T and XT devices for proper power-on and configuration. If the current minimums shown in **Table 6** and **Table 7** are met, the device powers on after all five supplies have passed through their power-on reset threshold voltages. The FPGA must not be configured until after  $V_{CCINT}$  is applied.

Once initialized and configured, use the XPower tools to estimate current drain on these supplies.

**Table 7: Power-On Current for Virtex-7 T and XT Devices**

Device	$I_{CCINTMIN}$	$I_{CCAUXMIN}$	$I_{CCOMIN}$	$I_{CCAUX\_IO}$	$I_{CCBRAM}$	Units
	$I_{CCINTQ}^{(1)}$	$I_{CCAUXQ}^{(1)}$	$I_{CCOQ}^{(1)}$	$I_{CCOAUQ}^{(1)}$	$I_{CCBRAMQ}^{(1)}$	
XC7V585T	$I_{CCINTQ} + 2700$	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 60 \text{ mA per bank}$	$I_{CCOAUQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 108$	mA
XC7V2000T	$I_{CCINTQ} + 4000$	$I_{CCAUXQ} + 80$	$I_{CCOQ} + 60 \text{ mA per bank}$	$I_{CCOAUQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 176$	mA
XC7VX330T	$I_{CCINTQ} + 1000$	$I_{CCAUXQ} + 65$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 95$	mA
XC7VX415T	$I_{CCINTQ} + 1200$	$I_{CCAUXQ} + 75$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 115$	mA
XC7VX485T	$I_{CCINTQ} + 1200$	$I_{CCAUXQ} + 80$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 140$	mA
XC7VX550T	$I_{CCINTQ} + 3300$	$I_{CCAUXQ} + 143$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUQ} + 57 \text{ mA per bank}$	$I_{CCBRAMQ} + 200$	mA
XC7VX690T	$I_{CCINTQ} + 3300$	$I_{CCAUXQ} + 143$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUQ} + 57 \text{ mA per bank}$	$I_{CCBRAMQ} + 200$	mA
XC7VX980T	$I_{CCINTQ} + 6500$	$I_{CCAUXQ} + 202$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUQ} + 60 \text{ mA per bank}$	$I_{CCBRAMQ} + 204$	mA
XC7VX1140T	$I_{CCINTQ} + 8000$	$I_{CCAUXQ} + 235$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUQ} + 63 \text{ mA per bank}$	$I_{CCBRAMQ} + 256$	mA

**Notes:**

1. Typical values are specified at nominal voltage, 25°C.
2. Use the Xilinx Power Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate maximum power-on currents.

**Table 8: Power Supply Ramp Time**

Symbol	Description	Conditions	Min	Max	Units
$T_{VCCINT}$	Ramp time from GND to 90% of $V_{CCINT}$		0.2	50	ms
$T_{VCCO}$	Ramp time from GND to 90% of $V_{CCO}$		0.2	50	ms
$T_{VCCAUX}$	Ramp time from GND to 90% of $V_{CCAUX}$		0.2	50	ms
$T_{VCCAUX\_IO}$	Ramp time from GND to 90% of $V_{CCAUX\_IO}$		0.2	50	ms
$T_{CCBRAM}$	Ramp time from GND to 90% of $V_{CCBRAM}$		0.2	50	ms
$T_{VCCO2VCCAUX}$	Allowed time per power cycle for $V_{CCO} - V_{CCAUX} > 2.625\text{V}$	$T_J = 100^\circ\text{C}^{(1)}$	–	500	ms
		$T_J = 85^\circ\text{C}^{(1)}$	–	800	
$T_{MGTAVCC}$	Ramp time from GND to 90% of $V_{MGTAVCC}$		0.2	50	ms
$T_{MGTAVTT}$	Ramp time from GND to 90% of $V_{MGTAVTT}$		0.2	50	ms
$T_{MGTVCCAUX}$	Ramp time from GND to 90% of $V_{MGTVCCAUX}$		0.2	50	ms

**Notes:**

1. Based on 240,000 power cycles with nominal  $V_{CCO}$  of 3.3V or 36,500 power cycles with a worst case  $V_{CCO}$  of 3.465V.

## LVDS DC Specifications (LVDS\_25)

The LVDS standard is available in the HR I/O banks.

**Table 12: LVDS\_25 DC Specifications<sup>(1)</sup>**

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
$V_{CCO}$	Supply voltage		2.375	2.500	2.625	V
$V_{OH}$	Output High voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	–	–	1.675	V
$V_{OL}$	Output Low voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	0.700	–	–	V
$V_{ODIFF}$	Differential output voltage ( $Q - \bar{Q}$ ), Q = High ( $Q - Q$ ), $\bar{Q}$ = High	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	247	350	600	mV
$V_{OCM}$	Output common-mode voltage	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	1.000	1.250	1.425	V
$V_{IDIFF}$	Differential input voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High		100	350	600	mV
$V_{ICM}$	Input common-mode voltage		0.300	1.200	1.425	V

**Notes:**

1. Differential inputs for LVDS\_25 can be placed in banks with  $V_{CCO}$  levels that are different from the required level for outputs. Consult the 7 Series FPGAs SelectIO Resources User Guide ([UG471](#)) for more information.

## LVDS DC Specifications (LVDS)

The LVDS standard is available in the HP I/O banks.

**Table 13: LVDS DC Specifications**

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
$V_{CCO}$	Supply voltage		1.710	1.800	1.890	V
$V_{OH}$	Output High voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	–	–	1.675	V
$V_{OL}$	Output Low voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	0.825	–	–	V
$V_{ODIFF}$	Differential output voltage ( $Q - \bar{Q}$ ), Q = High ( $Q - Q$ ), $\bar{Q}$ = High	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	247	350	600	mV
$V_{OCM}$	Output common-mode voltage	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	1.000	1.250	1.425	V
$V_{IDIFF}$	Differential input voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High	Common-mode input voltage = 1.25V	100	350	600	mV
$V_{ICM}$	Input common-mode voltage	Differential input voltage = ±350 mV	0.300	1.200	1.425	V

**Notes:**

1. Differential inputs for LVDS can be placed in banks with  $V_{CCO}$  levels that are different from the required level for outputs. Consult the 7 Series FPGAs SelectIO Resources User Guide ([UG471](#)) for more information.

## IOB Pad Input/Output/3-State

**Table 19** (3.3V high-range IOB (HR)) and **Table 20** (1.8V high-performance IOB (HP)) summarizes the values of standard-specific data input delay adjustments, output delays terminating at pads (based on standard) and 3-state delays.

- $T_{IOPI}$  is described as the delay from IOB pad through the input buffer to the I-pin of an IOB pad. The delay varies depending on the capability of the SelectIO input buffer.
- $T_{IOOP}$  is described as the delay from the O pin to the IOB pad through the output buffer of an IOB pad. The delay varies depending on the capability of the SelectIO output buffer.
- $T_{IOTP}$  is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is disabled. The delay varies depending on the SelectIO capability of the output buffer. In HP I/O banks, the internal DCI termination turn-on time is always faster than  $T_{IOTP}$  when the DCITERMDISABLE pin is used. In HR I/O banks, the IN\_TERM termination turn-on time is always faster than  $T_{IOTP}$  when the INTERMDISABLE pin is used.

Table 19: 3.3V IOB High Range (HR) Switching Characteristics

I/O Standard	$T_{IOPI}$			$T_{IOOP}$			$T_{IOTP}$			Units	
	Speed Grade			Speed Grade			Speed Grade				
	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1		
LVTTL_S4	1.31	1.42	1.64	3.77	3.90	4.00	4.53	4.76	4.99	ns	
LVTTL_S8	1.31	1.42	1.64	3.50	3.64	3.73	4.26	4.50	4.72	ns	
LVTTL_S12	1.31	1.42	1.64	3.49	3.62	3.72	4.25	4.48	4.71	ns	
LVTTL_S16	1.31	1.42	1.64	3.03	3.17	3.26	3.79	4.03	4.25	ns	
LVTTL_S24	1.31	1.42	1.64	3.25	3.39	3.48	4.01	4.25	4.47	ns	
LVTTL_F4	1.31	1.42	1.64	3.22	3.36	3.45	3.98	4.22	4.44	ns	
LVTTL_F8	1.31	1.42	1.64	2.71	2.84	2.93	3.47	3.70	3.92	ns	
LVTTL_F12	1.31	1.42	1.64	2.69	2.82	2.92	3.45	3.68	3.91	ns	
LVTTL_F16	1.31	1.42	1.64	2.57	2.85	3.15	3.33	3.71	4.14	ns	
LVTTL_F24	1.31	1.42	1.64	2.41	2.64	2.89	3.17	3.50	3.88	ns	
LVDS_25 <sup>(1)</sup>	0.64	0.68	0.80	1.36	1.47	1.55	2.12	2.33	2.54	ns	
MINI_LVDS_25	0.68	0.70	0.79	1.36	1.47	1.55	2.12	2.33	2.54	ns	
BLVDS_25 <sup>(1)</sup>	0.65	0.69	0.80	1.83	2.02	2.20	2.59	2.88	3.19	ns	
RSDS_25 (point to point) <sup>(1)</sup>	0.63	0.68	0.79	1.36	1.48	1.55	2.12	2.34	2.54	ns	
PPDS_25 <sup>(1)</sup>	0.65	0.69	0.80	1.36	1.49	1.58	2.12	2.35	2.57	ns	
TMDS_33 <sup>(1)</sup>	0.72	0.76	0.86	1.43	1.54	1.60	2.19	2.40	2.59	ns	
PCI33_3 <sup>(1)</sup>	1.28	1.41	1.65	2.71	3.08	3.52	3.47	3.94	4.51	ns	
HSUL_12	0.63	0.64	0.71	1.77	1.90	2.00	2.53	2.76	2.99	ns	
DIFF_HSUL_12	0.58	0.61	0.70	1.55	1.68	1.78	2.31	2.54	2.77	ns	
HSTL_I_S	0.61	0.64	0.73	1.55	1.69	1.80	2.31	2.55	2.79	ns	
HSTL_II_S	0.61	0.64	0.73	1.21	1.34	1.43	1.97	2.20	2.42	ns	
HSTL_I_18_S	0.64	0.67	0.76	1.28	1.39	1.45	2.04	2.25	2.44	ns	
HSTL_II_18_S	0.64	0.67	0.76	1.18	1.31	1.40	1.94	2.17	2.39	ns	
DIFF_HSTL_I_S	0.63	0.67	0.77	1.42	1.54	1.61	2.18	2.40	2.60	ns	
DIFF_HSTL_II_S	0.63	0.67	0.77	1.15	1.24	1.27	1.91	2.10	2.26	ns	
DIFF_HSTL_I_18_S	0.65	0.69	0.78	1.27	1.38	1.43	2.03	2.24	2.42	ns	
DIFF_HSTL_II_18_S	0.65	0.69	0.78	1.14	1.23	1.26	1.90	2.09	2.25	ns	
HSTL_I_F	0.61	0.64	0.73	1.10	1.19	1.23	1.86	2.05	2.22	ns	

Table 19: 3.3V IOB High Range (HR) Switching Characteristics (Cont'd)

I/O Standard	T <sub>IOPI</sub>			T <sub>IOOP</sub>			T <sub>IOTP</sub>			Units	
	Speed Grade			Speed Grade			Speed Grade				
	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1		
HSTL_II_F	0.61	0.64	0.73	1.05	1.18	1.28	1.81	2.04	2.27	ns	
HSTL_I_18_F	0.64	0.67	0.76	1.05	1.18	1.28	1.81	2.04	2.27	ns	
HSTL_II_18_F	0.64	0.67	0.76	1.03	1.14	1.23	1.79	2.00	2.22	ns	
DIFF_HSTL_I_F	0.63	0.67	0.77	1.09	1.18	1.22	1.85	2.04	2.21	ns	
DIFF_HSTL_II_F	0.63	0.67	0.77	1.02	1.11	1.14	1.78	1.97	2.13	ns	
DIFF_HSTL_I_18_F	0.65	0.69	0.78	1.08	1.17	1.21	1.84	2.03	2.20	ns	
DIFF_HSTL_II_18_F	0.65	0.69	0.78	1.01	1.10	1.13	1.77	1.96	2.12	ns	
LVCMOS33_S4	1.31	1.40	1.60	3.77	3.90	4.00	4.53	4.76	4.99	ns	
LVCMOS33_S8	1.31	1.40	1.60	3.49	3.62	3.72	4.25	4.48	4.71	ns	
LVCMOS33_S12	1.31	1.40	1.60	3.05	3.18	3.28	3.81	4.04	4.27	ns	
LVCMOS33_S16	1.31	1.40	1.60	3.06	3.43	3.88	3.82	4.29	4.87	ns	
LVCMOS33_F4	1.31	1.40	1.60	3.22	3.36	3.45	3.98	4.22	4.44	ns	
LVCMOS33_F8	1.31	1.40	1.60	2.71	2.84	2.93	3.47	3.70	3.92	ns	
LVCMOS33_F12	1.31	1.40	1.60	2.57	2.85	3.15	3.33	3.71	4.14	ns	
LVCMOS33_F16	1.31	1.40	1.60	2.44	2.69	2.96	3.20	3.55	3.95	ns	
LVCMOS25_S4	1.08	1.16	1.32	3.08	3.22	3.31	3.84	4.08	4.30	ns	
LVCMOS25_S8	1.08	1.16	1.32	2.85	2.98	3.07	3.61	3.84	4.06	ns	
LVCMOS25_S12	1.08	1.16	1.32	2.44	2.57	2.67	3.20	3.43	3.66	ns	
LVCMOS25_S16	1.08	1.16	1.32	2.79	2.92	3.01	3.55	3.78	4.00	ns	
LVCMOS25_F4	1.08	1.16	1.32	2.71	2.84	2.93	3.47	3.70	3.92	ns	
LVCMOS25_F8	1.08	1.16	1.32	2.14	2.28	2.37	2.90	3.14	3.36	ns	
LVCMOS25_F12	1.08	1.16	1.32	2.15	2.29	2.52	2.91	3.15	3.51	ns	
LVCMOS25_F16	1.08	1.16	1.32	1.92	2.17	2.45	2.68	3.03	3.44	ns	
LVCMOS18_S4	0.64	0.66	0.74	1.55	1.68	1.78	2.31	2.54	2.77	ns	
LVCMOS18_S8	0.64	0.66	0.74	2.14	2.28	2.37	2.90	3.14	3.36	ns	
LVCMOS18_S12	0.64	0.66	0.74	2.14	2.28	2.37	2.90	3.14	3.36	ns	
LVCMOS18_S16	0.64	0.66	0.74	1.49	1.62	1.72	2.25	2.48	2.71	ns	
LVCMOS18_S24 <sup>(1)</sup>	0.64	0.66	0.74	1.74	1.92	2.08	2.50	2.78	3.07	ns	
LVCMOS18_F4	0.64	0.66	0.74	1.38	1.51	1.61	2.14	2.37	2.60	ns	
LVCMOS18_F8	0.64	0.66	0.74	1.64	1.78	1.87	2.40	2.64	2.86	ns	
LVCMOS18_F12	0.64	0.66	0.74	1.64	1.78	1.87	2.40	2.64	2.86	ns	
LVCMOS18_F16	0.64	0.66	0.74	1.52	1.68	1.81	2.28	2.54	2.80	ns	
LVCMOS18_F24 <sup>(1)</sup>	0.64	0.66	0.74	1.34	1.46	1.55	2.10	2.32	2.54	ns	
LVCMOS15_S4	0.66	0.69	0.81	1.86	2.00	2.09	2.62	2.86	3.08	ns	
LVCMOS15_S8	0.66	0.69	0.81	2.05	2.18	2.28	2.81	3.04	3.27	ns	
LVCMOS15_S12	0.66	0.69	0.81	1.83	2.03	2.23	2.59	2.89	3.22	ns	
LVCMOS15_S16	0.66	0.69	0.81	1.76	1.95	2.13	2.52	2.81	3.12	ns	

Table 20: 1.8V IOB High Performance (HP) Switching Characteristics (Cont'd)

I/O Standard	T <sub>IOPI</sub>			T <sub>IOOP</sub>			T <sub>IOTP</sub>			Units	
	Speed Grade			Speed Grade			Speed Grade				
	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1		
SSTL15_F	0.68	0.72	0.82	0.89	1.01	1.09	1.53	1.77	1.91	ns	
SSTL15_DCI_F	0.68	0.72	0.82	0.89	1.01	1.09	1.53	1.77	1.91	ns	
SSTL15_T_DCI_F	0.68	0.72	0.82	0.89	1.01	1.09	1.53	1.77	1.91	ns	
SSTL135_F	0.69	0.72	0.82	0.88	1.00	1.08	1.52	1.76	1.90	ns	
SSTL135_DCI_F	0.69	0.72	0.82	0.89	1.00	1.08	1.52	1.76	1.90	ns	
SSTL135_T_DCI_F	0.69	0.72	0.82	0.89	1.00	1.08	1.52	1.76	1.90	ns	
SSTL12_F	0.69	0.72	0.82	0.88	1.00	1.08	1.52	1.76	1.90	ns	
SSTL12_DCI_F	0.69	0.72	0.82	0.91	1.03	1.11	1.54	1.79	1.93	ns	
SSTL12_T_DCI_F	0.69	0.72	0.82	0.91	1.03	1.11	1.54	1.79	1.93	ns	
DIFF_SSTL18_I_F	0.75	0.79	0.92	0.94	1.06	1.15	1.58	1.82	1.97	ns	
DIFF_SSTL18_II_F	0.75	0.79	0.92	0.97	1.09	1.16	1.61	1.84	1.99	ns	
DIFF_SSTL18_I_DCI_F	0.75	0.79	0.92	0.89	1.02	1.10	1.53	1.77	1.92	ns	
DIFF_SSTL18_II_DCI_F	0.75	0.79	0.92	0.89	1.02	1.10	1.53	1.77	1.92	ns	
DIFF_SSTL18_II_T_DCI_F	0.75	0.79	0.92	0.89	1.02	1.10	1.53	1.77	1.92	ns	
DIFF_SSTL15_F	0.68	0.72	0.82	0.89	1.01	1.09	1.53	1.77	1.91	ns	
DIFF_SSTL15_DCI_F	0.68	0.72	0.82	0.89	1.01	1.09	1.53	1.77	1.91	ns	
DIFF_SSTL15_T_DCI_F	0.68	0.72	0.82	0.89	1.01	1.09	1.53	1.77	1.91	ns	
DIFF_SSTL135_F	0.69	0.72	0.82	0.88	1.00	1.08	1.52	1.76	1.90	ns	
DIFF_SSTL135_DCI_F	0.69	0.72	0.82	0.89	1.00	1.08	1.52	1.76	1.90	ns	
DIFF_SSTL135_T_DCI_F	0.69	0.72	0.82	0.89	1.00	1.08	1.52	1.76	1.90	ns	
DIFF_SSTL12_F	0.69	0.72	0.82	0.88	1.00	1.08	1.52	1.76	1.90	ns	
DIFF_SSTL12_DCI_F	0.69	0.72	0.82	0.91	1.03	1.11	1.54	1.79	1.93	ns	
DIFF_SSTL12_T_DCI_F	0.69	0.72	0.82	0.91	1.03	1.11	1.54	1.79	1.93	ns	

**Notes:**

1. This I/O standard is only available in the 1.8V high-performance (HP) banks.

Table 21 specifies the values of T<sub>IOTPHZ</sub> and T<sub>IOIBUFDISABLE</sub>. T<sub>IOTPHZ</sub> is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is enabled (i.e., a high impedance state). T<sub>IOIBUFDISABLE</sub> is described as the IOB delay from IBUFDISABLE to O output. In HP I/O banks, the internal DCI termination turn-off time is always faster than T<sub>IOTPHZ</sub> when the DCITERMDISABLE pin is used. In HR I/O banks, the internal IN\_TERM termination turn-off time is always faster than T<sub>IOTPHZ</sub> when the INTERMDISABLE pin is used.

Table 21: IOB 3-state Output Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
T <sub>IOTPHZ</sub>	T input to pad high-impedance	0.76	0.86	0.99	ns
T <sub>IOIBUFDISABLE_HR</sub>	IBUF turn-on time from IBUFDISABLE to O output for HR I/O banks	1.72	1.89	2.14	ns
T <sub>IOIBUFDISABLE_HP</sub>	IBUF turn-on time from IBUFDISABLE to O output for HP I/O banks	1.31	1.46	1.76	ns

## Input/Output Logic Switching Characteristics

Table 22: ILOGIC Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Setup/Hold</b>					
T <sub>ICE1CK/T<sub>ICKCE1</sub></sub>	CE1 pin setup/hold with respect to CLK	0.42/0.00	0.48/0.00	0.67/0.00	ns
T <sub>ISRCK/T<sub>ICKSR</sub></sub>	SR pin setup/hold with respect to CLK	0.53/0.01	0.61/0.01	0.99/0.01	ns
T <sub>IDOCKE2/T<sub>IOCKDE2</sub></sub>	D pin setup/hold with respect to CLK without delay (HP I/O banks only)	0.01/0.27	0.01/0.29	0.01/0.34	ns
T <sub>IDOCKDE2/T<sub>IOCKDDE2</sub></sub>	DDLY pin setup/hold with respect to CLK (using IDELAY) (HP I/O banks only)	0.01/0.27	0.02/0.29	0.02/0.34	ns
T <sub>IDOCKE3/T<sub>IOCKDE3</sub></sub>	D pin setup/hold with respect to CLK without delay (HR I/O banks only)	0.01/0.27	0.01/0.29	0.01/0.34	ns
T <sub>IDOCKDE3/T<sub>IOCKDDE3</sub></sub>	DDLY pin setup/hold with respect to CLK (using IDELAY) (HR I/O banks only)	0.01/0.27	0.02/0.29	0.02/0.34	ns
<b>Combinatorial</b>					
T <sub>IDIE2</sub>	D pin to O pin propagation delay, no delay (HP I/O banks only)	0.09	0.10	0.12	ns
T <sub>IDIDE2</sub>	DDLY pin to O pin propagation delay (using IDELAY) (HP I/O banks only)	0.10	0.11	0.13	ns
T <sub>IDIE3</sub>	D pin to O pin propagation delay, no delay (HR I/O banks only)	0.09	0.10	0.12	ns
T <sub>IDIDE3</sub>	DDLY pin to O pin propagation delay (using IDELAY) (HR I/O banks only)	0.10	0.11	0.13	ns
<b>Sequential Delays</b>					
T <sub>IDLOE2</sub>	D pin to Q1 pin using flip-flop as a latch without delay (HP I/O banks only)	0.36	0.39	0.45	ns
T <sub>IDLODE2</sub>	DDLY pin to Q1 pin using flip-flop as a latch (using IDELAY) (HP I/O banks only)	0.36	0.39	0.45	ns
T <sub>IDLOE3</sub>	D pin to Q1 pin using flip-flop as a latch without delay (HR I/O banks only)	0.36	0.39	0.45	ns
T <sub>IDLODE3</sub>	DDLY pin to Q1 pin using flip-flop as a latch (using IDELAY) (HR I/O banks only)	0.36	0.39	0.45	ns
T <sub>ICKQ</sub>	CLK to Q outputs	0.47	0.50	0.58	ns
T <sub>RQ_ILOGICE2</sub>	SR pin to OQ/TQ out (HP I/O banks only)	0.84	0.94	1.16	ns
T <sub>GSRQ_ILOGICE2</sub>	Global set/reset to Q outputs (HP I/O banks only)	7.60	7.60	10.51	ns
T <sub>RQ_ILOGICE3</sub>	SR pin to OQ/TQ out (HR I/O banks only)	0.84	0.94	1.16	ns
T <sub>GSRQ_ILOGICE3</sub>	Global set/reset to Q outputs (HR I/O banks only)	7.60	7.60	10.51	ns
<b>Set/Reset</b>					
T <sub>RPW_ILOGICE2</sub>	Minimum pulse width, SR inputs (HP I/O banks only)	0.54	0.63	0.63	ns, Min
T <sub>RPW_ILOGICE3</sub>	Minimum pulse width, SR inputs (HR I/O banks only)	0.54	0.63	0.63	ns, Min

Table 27: IO\_FIFO Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>IO_FIFO Clock to Out Delays</b>					
T <sub>OFFCKO_DO</sub>	RDCLK to Q outputs	0.51	0.56	0.63	ns
T <sub>CKO_FLAGS</sub>	Clock to IO_FIFO flags	0.59	0.62	0.81	ns
<b>Setup/Hold</b>					
T <sub>CCK_D</sub> /T <sub>CKC_D</sub>	D inputs to WRCLK	0.43/-0.01	0.47/-0.01	0.53/-0.01	ns
T <sub>IFFCCK_WREN</sub> /T <sub>IFFCKC_WREN</sub>	WREN to WRCLK	0.39/-0.01	0.43/-0.01	0.50/-0.01	ns
T <sub>OFFCCK_RDEN</sub> /T <sub>OFFCKC_RDEN</sub>	RDEN to RDCLK	0.49/0.01	0.53/0.02	0.61/0.02	ns
<b>Minimum Pulse Width</b>					
T <sub>PWH_IO_FIFO</sub>	RESET, RDCLK, WRCLK	0.81	0.92	1.08	ns
T <sub>PWL_IO_FIFO</sub>	RESET, RDCLK, WRCLK	0.81	0.92	1.08	ns
<b>Maximum Frequency</b>					
F <sub>MAX</sub>	RDCLK and WRCLK	533.05	470.37	400.00	MHz

## CLB Distributed RAM Switching Characteristics (SLICEM Only)

Table 29: CLB Distributed RAM Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Sequential Delays</b>					
T <sub>SHCKO</sub> <sup>(1)</sup>	Clock to A – B outputs	0.68	0.70	0.85	ns, Max
T <sub>SHCKO_1</sub>	Clock to AMUX – BMUX outputs	0.91	0.95	1.15	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>					
T <sub>DS_LRAM</sub> /T <sub>DH_LRAM</sub>	A – D inputs to CLK	0.45/0.23	0.45/0.24	0.54/0.27	ns, Min
T <sub>AS_LRAM</sub> /T <sub>AH_LRAM</sub>	Address An inputs to clock	0.13/0.50	0.14/0.50	0.17/0.58	ns, Min
	Address An inputs through MUXs and/or carry logic to clock	0.40/0.16	0.42/0.17	0.52/0.23	ns, Min
T <sub>WS_LRAM</sub> /T <sub>WH_LRAM</sub>	WE input to clock	0.29/0.09	0.30/0.09	0.36/0.09	ns, Min
T <sub>CECK_LRAM</sub> /T <sub>CKCE_LRAM</sub>	CE input to CLK	0.29/0.09	0.30/0.09	0.37/0.09	ns, Min
<b>Clock CLK</b>					
T <sub>MPW</sub>	Minimum pulse width	0.68	0.77	0.91	ns, Min
T <sub>MCP</sub>	Minimum clock period	1.35	1.54	1.82	ns, Min

**Notes:**

1. T<sub>SHCKO</sub> also represents the CLK to XMUX output. Refer to the timing report for the CLK to XMUX path.

## CLB Shift Register Switching Characteristics (SLICEM Only)

Table 30: CLB Shift Register Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Sequential Delays</b>					
T <sub>REG</sub>	Clock to A – D outputs	0.96	0.98	1.20	ns, Max
T <sub>REG_MUX</sub>	Clock to AMUX – DMUX output	1.19	1.23	1.50	ns, Max
T <sub>REG_M31</sub>	Clock to DMUX output via M31 output	0.89	0.91	1.10	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>					
T <sub>WS_SHFREG</sub> /T <sub>WH_SHFREG</sub>	WE input	0.26/0.09	0.27/0.09	0.33/0.09	ns, Min
T <sub>CECK_SHFREG</sub> /T <sub>CKCE_SHFREG</sub>	CE input to CLK	0.27/0.09	0.28/0.09	0.33/0.09	ns, Min
T <sub>DS_SHFREG</sub> /T <sub>DH_SHFREG</sub>	A – D inputs to CLK	0.28/0.26	0.28/0.26	0.33/0.30	ns, Min
<b>Clock CLK</b>					
T <sub>MPW_SHFREG</sub>	Minimum pulse width	0.55	0.65	0.78	ns, Min

Table 31: Block RAM and FIFO Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Maximum Frequency</b>					
F <sub>MAX_BRAM_WF_NC</sub>	Block RAM (Write first and No change modes) When not in SDP RF mode	601.32	543.77	458.09	MHz
F <sub>MAX_BRAM_RF_PERFORMANCE</sub>	Block RAM (Read first, Performance mode) When in SDP RF mode but no address overlap between port A and port B	601.32	543.77	458.09	MHz
F <sub>MAX_BRAM_RF_DELAYED_WRITE</sub>	Block RAM (Read first, Delayed_write mode) When in SDP RF mode and there is possibility of overlap between port A and port B addresses	528.26	477.33	400.80	MHz
F <sub>MAX_CAS_WF_NC</sub>	Block RAM Cascade (Write first, No change mode) When cascade but not in RF mode	551.27	493.83	408.00	MHz
F <sub>MAX_CAS_RF_PERFORMANCE</sub>	Block RAM Cascade (Read first, Performance mode) When in cascade with RF mode and no possibility of address overlap/one port is disabled	551.27	493.83	408.00	MHz
F <sub>MAX_CAS_RF_DELAYED_WRITE</sub>	When in cascade RF mode and there is a possibility of address overlap between port A and port B	478.24	427.35	350.88	MHz
F <sub>MAX_FIFO</sub>	FIFO in all modes without ECC	601.32	543.77	458.09	MHz
F <sub>MAX_ECC</sub>	Block RAM and FIFO in ECC configuration	484.26	430.85	351.12	MHz

**Notes:**

1. The timing report shows all of these parameters as T<sub>RCKO\_DO</sub>.
2. T<sub>RCKO\_DOR</sub> includes T<sub>RCKO\_DOW</sub>, T<sub>RCKO\_DOPR</sub>, and T<sub>RCKO\_DOPW</sub> as well as the B port equivalent timing parameters.
3. These parameters also apply to synchronous FIFO with DO\_REG = 0.
4. T<sub>RCKO\_DO</sub> includes T<sub>RCKO\_DOP</sub> as well as the B port equivalent timing parameters.
5. These parameters also apply to multirate (asynchronous) and synchronous FIFO with DO\_REG = 1.
6. T<sub>RCKO\_FLAGS</sub> includes the following parameters: T<sub>RCKO\_AEMPTY</sub>, T<sub>RCKO\_AFULL</sub>, T<sub>RCKO\_EMPTY</sub>, T<sub>RCKO\_FULL</sub>, T<sub>RCKO\_RDERR</sub>, T<sub>RCKO\_WRERR</sub>.
7. T<sub>RCKO\_POINTERS</sub> includes both T<sub>RCKO\_RDCOUNT</sub> and T<sub>RCKO\_WRCOUNT</sub>.
8. The ADDR setup and hold must be met when EN is asserted (even when WE is deasserted). Otherwise, block RAM data corruption is possible.
9. These parameters include both A and B inputs as well as the parity inputs of A and B.
10. T<sub>RCKO\_FLAGS</sub> includes the following flags: AEMPTY, AFULL, EMPTY, FULL, RDERR, WRERR, RDCOUNT, and WRCOUNT.
11. RDEN and WREN must be held Low prior to and during reset. The FIFO reset must be asserted for at least five positive clock edges of the slowest clock (WRCLK or RDCLK).

## DSP48E1 Switching Characteristics

Table 32: DSP48E1 Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Setup and Hold Times of Data/Control Pins to the Input Register Clock</b>					
$T_{DSPDCK\_A\_AREG}/T_{DSPCKD\_A\_AREG}$	A input to A register CLK	0.24/0.12	0.27/0.14	0.31/0.16	ns
$T_{DSPDCK\_B\_BREG}/T_{DSPCKD\_B\_BREG}$	B input to B register CLK	0.28/0.13	0.32/0.14	0.39/0.15	ns
$T_{DSPDCK\_C\_CREG}/T_{DSPCKD\_C\_CREG}$	C input to C register CLK	0.15/0.15	0.17/0.17	0.20/0.20	ns
$T_{DSPDCK\_D\_DREG}/T_{DSPCKD\_D\_DREG}$	D input to D register CLK	0.21/0.19	0.27/0.22	0.35/0.26	ns
$T_{DSPDCK\_ACIN\_AREG}/T_{DSPCKD\_ACIN\_AREG}$	ACIN input to A register CLK	0.21/0.12	0.24/0.14	0.27/0.16	ns
$T_{DSPDCK\_BCIN\_BREG}/T_{DSPCKD\_BCIN\_BREG}$	BCIN input to B register CLK	0.22/0.13	0.25/0.14	0.30/0.15	ns
<b>Setup and Hold Times of Data Pins to the Pipeline Register Clock</b>					
$T_{DSPDCK\_{A,B}\_MREG\_MULT}/T_{DSPCKD\_{A,B}\_MREG\_MULT}$	{A, B,} input to M register CLK using multiplier	2.04/-0.01	2.34/-0.01	2.79/-0.01	ns
$T_{DSPDCK\_{A,B}\_ADREG}/T_{DSPCKD\_{A,B}\_ADREG}$	{A, D} input to AD register CLK	1.09/-0.02	1.25/-0.02	1.49/-0.02	ns
<b>Setup and Hold Times of Data/Control Pins to the Output Register Clock</b>					
$T_{DSPDCK\_{A,B}\_PREG\_MULT}/T_{DSPCKD\_{A,B}\_PREG\_MULT}$	{A, B,} input to P register CLK using multiplier	3.41/-0.24	3.90/-0.24	4.64/-0.24	ns
$T_{DSPDCK\_D\_PREG\_MULT}/T_{DSPCKD\_D\_PREG\_MULT}$	D input to P register CLK using multiplier	3.33/-0.62	3.81/-0.62	4.53/-0.62	ns
$T_{DSPDCK\_{A,B}\_PREG}/T_{DSPCKD\_{A,B}\_PREG}$	A or B input to P register CLK not using multiplier	1.47/-0.24	1.68/-0.24	2.00/-0.24	ns
$T_{DSPDCK\_C\_PREG}/T_{DSPCKD\_C\_PREG}$	C input to P register CLK not using multiplier	1.30/-0.22	1.49/-0.22	1.78/-0.22	ns
$T_{DSPDCK\_PCIN\_PREG}/T_{DSPCKD\_PCIN\_PREG}$	PCIN input to P register CLK	1.12/-0.13	1.28/-0.13	1.52/-0.13	ns
<b>Setup and Hold Times of the CE Pins</b>					
$T_{DSPDCK\_{CEA;CEB}\_{AREG;BREG}}/T_{DSPCKD\_{CEA;CEB}\_{AREG;BREG}}$	{CEA; CEB} input to {A; B} register CLK	0.30/0.05	0.36/0.06	0.44/0.09	ns
$T_{DSPDCK\_CEC\_CREG}/T_{DSPCKD\_CEC\_CREG}$	CEC input to C register CLK	0.24/0.08	0.29/0.09	0.36/0.11	ns
$T_{DSPDCK\_CED\_DREG}/T_{DSPCKD\_CED\_DREG}$	CED input to D register CLK	0.31/-0.02	0.36/-0.02	0.44/-0.02	ns
$T_{DSPDCK\_CEM\_MREG}/T_{DSPCKD\_CEM\_MREG}$	CEM input to M register CLK	0.26/0.15	0.29/0.17	0.33/0.20	ns
$T_{DSPDCK\_CEP\_PREG}/T_{DSPCKD\_CEP\_PREG}$	CEP input to P register CLK	0.31/0.01	0.36/0.01	0.45/0.01	ns
<b>Setup and Hold Times of the RST Pins</b>					
$T_{DSPDCK\_{RSTA;RSTB}\_{AREG;BREG}}/T_{DSPCKD\_{RSTA;RSTB}\_{AREG;BREG}}$	{RSTA, RSTB} input to {A, B} register CLK	0.34/0.10	0.39/0.11	0.47/0.13	ns
$T_{DSPDCK\_RSTC\_CREG}/T_{DSPCKD\_RSTC\_CREG}$	RSTC input to C register CLK	0.06/0.22	0.07/0.24	0.08/0.26	ns
$T_{DSPDCK\_RSTD\_DREG}/T_{DSPCKD\_RSTD\_DREG}$	RSTD input to D register CLK	0.37/0.06	0.42/0.06	0.50/0.07	ns
$T_{DSPDCK\_RSTM\_MREG}/T_{DSPCKD\_RSTM\_MREG}$	RSTM input to M register CLK	0.18/0.18	0.20/0.21	0.23/0.24	ns
$T_{DSPDCK\_RSTP\_PREG}/T_{DSPCKD\_RSTP\_PREG}$	RSTP input to P register CLK	0.24/0.01	0.26/0.01	0.30/0.01	ns
<b>Combinatorial Delays from Input Pins to Output Pins</b>					
$T_{DSPDO\_A\_CARRYOUT\_MULT}$	A input to CARRYOUT output using multiplier	3.21	3.69	4.39	ns
$T_{DSPDO\_D\_P\_MULT}$	D input to P output using multiplier	3.15	3.61	4.30	ns

Table 32: DSP48E1 Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Clock to Outs from Input Register Clock to Cascading Output Pins</b>					
T <sub>DSPCKO_(ACOUT; BCOUT)_(AREG; BREG)</sub>	CLK (ACOUT, BCOUT) to {A,B} register output	0.55	0.62	0.74	ns
T <sub>DSPCKO_CARRYCASOUT_{AREG, BREG}_MULT</sub>	CLK (AREG, BREG) to CARRYCASOUT output using multiplier	3.55	4.06	4.84	ns
T <sub>DSPCKO_CARRYCASOUT_BREG</sub>	CLK (BREG) to CARRYCASOUT output not using multiplier	1.60	1.82	2.16	ns
T <sub>DSPCKO_CARRYCASOUT_DREG_MULT</sub>	CLK (DREG) to CARRYCASOUT output using multiplier	3.52	4.03	4.79	ns
T <sub>DSPCKO_CARRYCASOUT_CREG</sub>	CLK (CREG) to CARRYCASOUT output	1.64	1.88	2.23	ns
<b>Maximum Frequency</b>					
F <sub>MAX</sub>	With all registers used	741.84	650.20	547.95	MHz
F <sub>MAX_PATDET</sub>	With pattern detector	627.35	549.75	463.61	MHz
F <sub>MAX_MULT_NOMREG</sub>	Two register multiply without MREG	412.20	360.75	303.77	MHz
F <sub>MAX_MULT_NOMREG_PATDET</sub>	Two register multiply without MREG with pattern detect	374.25	327.65	276.01	MHz
F <sub>MAX_PREADD_MULT_NOADREG</sub>	Without ADREG	468.82	408.66	342.70	MHz
F <sub>MAX_PREADD_MULT_NOADREG_PATDET</sub>	Without ADREG with pattern detect	468.82	408.66	342.58	MHz
F <sub>MAX_NOPIPELINEREG</sub>	Without pipeline registers (MREG, ADREG)	306.84	267.81	225.02	MHz
F <sub>MAX_NOPIPELINEREG_PATDET</sub>	Without pipeline registers (MREG, ADREG) with pattern detect	285.23	249.13	209.38	MHz

## Device Pin-to-Pin Output Parameter Guidelines

All devices are 100% functionally tested. Values are expressed in nanoseconds unless otherwise noted.

**Table 40: Clock-Capable Clock Input to Output Delay Without MMCM/PLL (Near Clock Region)**

Symbol	Description	Device	Speed Grade			Units
			-3	-2/-2L/-2G	-1	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, <i>without</i> MMCM/PLL.						
TICKOF	Clock-capable clock input and OUTFF <i>without</i> MMCM/PLL (near clock region)	XC7V585T	5.63	6.20	6.97	ns
		XC7V2000T	N/A	5.66	6.35	ns
		XC7VX330T	5.41	5.97	6.71	ns
		XC7VX415T	5.46	5.96	6.70	ns
		XC7VX485T	5.29	5.84	6.57	ns
		XC7VX550T	5.45	6.02	6.76	ns
		XC7VX690T	5.46	6.02	6.76	ns
		XC7VX980T	N/A	6.12	6.87	ns
		XC7VX1140T	N/A	5.59	6.28	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net in a single SLR.

**Table 41: Clock-Capable Clock Input to Output Delay Without MMCM/PLL (Far Clock Region)**

Symbol	Description	Device	Speed Grade			Units
			-3	-2/-2L/-2G	-1	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, <i>without</i> MMCM/PLL.						
TICKOFFAR	Clock-capable clock input and OUTFF <i>without</i> MMCM/PLL (far clock region)	XC7V585T	6.81	7.53	8.44	ns
		XC7V2000T	N/A	6.00	6.73	ns
		XC7VX330T	6.31	6.97	7.83	ns
		XC7VX415T	6.36	6.90	7.69	ns
		XC7VX485T	6.20	6.86	7.69	ns
		XC7VX550T	6.66	7.37	8.27	ns
		XC7VX690T	6.69	7.37	8.27	ns
		XC7VX980T	N/A	7.47	8.37	ns
		XC7VX1140T	N/A	5.93	6.65	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net in a single SLR.

## Additional Package Parameter Guidelines

The parameters in this section provide the necessary values for calculating timing budgets for Virtex-7 T and XT FPGA clock transmitter and receiver data-valid windows.

*Table 50: Package Skew*

Symbol	Description	Device	Package	Value	Units
$T_{PKGSKEW}$	Package Skew <sup>(1)</sup>	XC7V585T	FFG1157	232	ps
			FFG1761	255	ps
		XC7V2000T	FHG1761	308	ps
			FLG1925	266	ps
		XC7VX330T	FFG1157	170	ps
			FFG1761	270	ps
		XC7VX415T	FFG1157	203	ps
			FFG1158	237	ps
			FFG1927	183	ps
		XC7VX485T	FFG1157	191	ps
			FFG1158	209	ps
			FFG1761	274	ps
			FFG1927	209	ps
			FFG1930	304	ps
		XC7VX550T	FFG1158	217	ps
			FFG1927	254	ps
		XC7VX690T	FFG1157	239	ps
			FFG1158	217	ps
			FFG1761	284	ps
			FFG1926	238	ps
			FFG1927	254	ps
			FFG1930	287	ps
		XC7VX980T	FFG1926	242	ps
			FFG1928	199	ps
			FFG1930	243	ps
		XC7VX1140T	FLG1926	271	ps
			FLG1928	216	ps
			FLG1930	279	ps

**Notes:**

1. These values represent the worst-case skew between any two SelectIO resources in the package: shortest delay to longest delay from die pad to ball.
2. Package delay information is available for these device/package combinations. This information can be used to deskew the package.

**Table 67** summarizes the DC specifications of the clock input of the GTH transceiver. Consult the *7 Series FPGAs GTX/GTH Transceiver User Guide* ([UG476](#)) for further details.

**Table 67: GTH Transceiver Clock DC Input Level Specification**

Symbol	DC Parameter	Min	Typ	Max	Units
V <sub>IDIFF</sub>	Differential peak-to-peak input voltage	350	—	2000	mV
R <sub>IN</sub>	Differential input resistance	—	100	—	Ω
C <sub>EXT</sub>	Required external AC coupling capacitor	—	100	—	nF

## GTH Transceiver Switching Characteristics

Consult the *7 Series FPGAs GTX/GTH Transceiver User Guide* ([UG476](#)) for further information.

**Table 68: GTH Transceiver Performance**

Symbol	Description	Output Divider	Speed Grade			Units	
			-3E/-2GE	-2(C&I)/-2LE	-1(C&I) <sup>(1)</sup>		
F <sub>GTHMAX</sub>	Maximum GTH transceiver data rate	13.1	11.3	8.5	8.5	Gb/s	
F <sub>GTHMIN</sub>	Minimum GTH transceiver data rate	0.500	0.500	0.500	0.500	Gb/s	
F <sub>GTHCRANGE</sub>	CPLL line rate range	1	3.2–10.3125			Gb/s	
		2	1.6–5.16			Gb/s	
		4	0.8–2.58			Gb/s	
		8	0.5–1.29			Gb/s	
		16	N/A			Gb/s	
F <sub>GTHQRANGE1</sub>	QPLL line rate range 1	1	8.0–11.85	8.0–11.3	8.0–8.5	Gb/s	
		2	4.0–5.925	4.0–5.65	4.0–4.25	Gb/s	
		4	2.0–2.9625	2.0–2.825	2.0–2.125	Gb/s	
		8	1.0–1.48125	1.0–1.4125	1.0–1.0625	Gb/s	
		16	N/A			Gb/s	
F <sub>GTHQRANGE2</sub>	QPLL line rate range 2	1	11.85–13.1	N/A			Gb/s
		2	5.925–6.55	N/A			Gb/s
		4	2.96–3.275	N/A			Gb/s
		8	1.48–1.63	N/A			Gb/s
		16	0.74–0.81	N/A			Gb/s
F <sub>GCPLLRANGE</sub>	GTH transceiver CPLL frequency range	1.6–5.16			1.6–4.0	GHz	
F <sub>GQPLL RANGE1</sub>	GTH transceiver QPLL frequency range 1	8.0–11.85	8.0–11.3	8.0–8.5		GHz	
F <sub>GQPLL RANGE2</sub>	GTH transceiver QPLL frequency range 2	11.85–13.1	N/A			GHz	

### Notes:

- The -1 speed grade requires a 4-byte internal data width for operation above 5.0 Gb/s. A -1 speed grade with V<sub>CCINT</sub> = 0.9V, as described in the *Lowering Power using the Voltage Identification Bit* application note ([XAPP555](#)), requires a 4-byte internal data width for operation above 3.8 Gb/s.

**Table 69: GTH Transceiver Dynamic Reconfiguration Port (DRP) Switching Characteristics**

Symbol	Description	Speed Grade				Units
		-3/-2G	-2L	-2	-1	
F <sub>GTHDRPCLK</sub>	GTHDRPCLK maximum frequency	175	175	175	156	MHz

Table 70: GTH Transceiver Reference Clock Switching Characteristics

Symbol	Description	Conditions	All Speed Grades			Units
			Min	Typ	Max	
$F_{GCLK}$	Reference clock frequency range		60	—	820	MHz
$T_{RCLK}$	Reference clock rise time	20% – 80%	—	200	—	ps
$T_{FCLK}$	Reference clock fall time	80% – 20%	—	200	—	ps
$T_{DCREF}$	Reference clock duty cycle	Transceiver PLL only	40	50	60	%

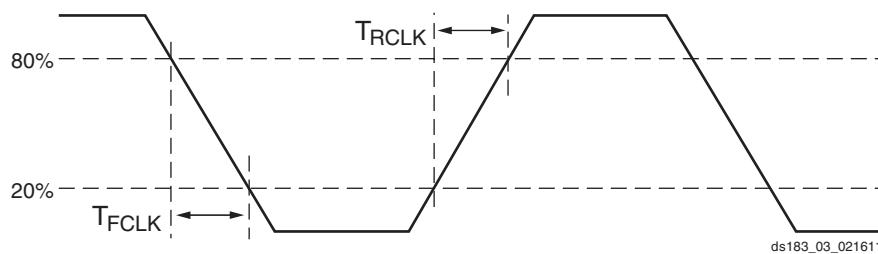


Figure 6: Reference Clock Timing Parameters

Table 71: GTH Transceiver PLL/Lock Time Adaptation

Symbol	Description	Conditions	All Speed Grades			Units
			Min	Typ	Max	
$T_{LOCK}$	Initial PLL lock		—	—	1	ms
$T_{DLOCK}$	Clock recovery phase acquisition and adaptation time for decision feedback equalizer (DFE).	After the PLL is locked to the reference clock, this is the time it takes to lock the clock data recovery (CDR) to the data present at the input.	—	50,000	$37 \times 10^6$	UI
	Clock recovery phase acquisition and adaptation time for low-power mode (LPM) when the DFE is disabled.		—	50,000	$2.3 \times 10^6$	UI

Table 72: GTH Transceiver User Clock Switching Characteristics<sup>(1)</sup>

Symbol	Description	Data Width Conditions		Speed Grade			Units
		Internal Logic	Interconnect Logic	-3E/-2GE <sup>(2)</sup>	-2(C&I)/-2LE <sup>(2)</sup>	-1(C&I) <sup>(3)</sup>	
F <sub>TXOUT</sub>	TXUSERCLKOUT maximum frequency			412.500	412.500	312.500	MHz
F <sub>RXOUT</sub>	RXUSERCLKOUT maximum frequency			412.500	412.500	312.500	MHz
F <sub>TXIN</sub>	TXUSERCLKIN maximum frequency	16-bit	16-bit and 32-bit	412.500	412.500	312.500	MHz
		32-bit	32-bit	409.375	353.125	265.625	MHz
F <sub>RXIN</sub>	RXUSERCLKIN maximum frequency	16-bit	16-bit and 32-bit	412.500	412.500	312.500	MHz
		32-bit	32-bit	409.375	353.125	265.625	MHz
F <sub>TXIN2</sub>	TXUSERCLKIN2 maximum frequency	16-bit	16-bit	412.500	412.500	312.500	MHz
		16-bit and 32-bit	32-bit	409.375	353.125	265.625	MHz
		64-bit	64-bit	204.688	176.563	132.813	MHz
F <sub>RXIN2</sub>	RXUSERCLKIN2 maximum frequency	16-bit	16-bit	412.500	412.500	312.500	MHz
		16-bit and 32-bit	32-bit	409.375	353.125	265.625	MHz
		64-bit	64-bit	204.688	176.563	132.813	MHz

**Notes:**

- Clocking must be implemented as described in the 7 Series FPGAs GTX/GTH Transceiver User Guide ([UG476](#)).
- For speed grades -3E, -2GE, -2C, -2L, and -2LE, a 16-bit data path can only be used for speeds less than 6.6 Gb/s.
- For speed grade -1 (and when V<sub>CCINT</sub> = 0.9V), a 16-bit data path can only be used for speeds less than 5.0 Gb/s.

Table 73: GTH Transceiver Transmitter Switching Characteristics

Symbol	Description	Condition	Min	Typ	Max	Units
F <sub>GTHTX</sub>	Serial data rate range		0.500	–	F <sub>GTHMAX</sub>	Gb/s
T <sub>RTX</sub>	TX rise time	20%–80%	–	40	–	ps
T <sub>FTX</sub>	TX fall time	80%–20%	–	40	–	ps
T <sub>LLSKEW</sub>	TX lane-to-lane skew <sup>(1)</sup>		–	–	500	ps
V <sub>TXOOBVDP</sub>	Electrical idle amplitude		–	–	15	mV
T <sub>TXOOBTRANSITION</sub>	Electrical idle transition time		–	–	140	ns
TJ <sub>13.1</sub>	Total jitter <sup>(2)(4)</sup>	13.1 Gb/s	–	–	0.3	UI
DJ <sub>13.1</sub>	Deterministic jitter <sup>(2)(4)</sup>		–	–	0.17	UI
TJ <sub>12.5</sub>	Total jitter <sup>(2)(4)</sup>	12.5 Gb/s	–	–	0.28	UI
DJ <sub>12.5</sub>	Deterministic jitter <sup>(2)(4)</sup>		–	–	0.17	UI
TJ <sub>11.3</sub>	Total jitter <sup>(2)(4)</sup>	11.3 Gb/s	–	–	0.28	UI
DJ <sub>11.3</sub>	Deterministic jitter <sup>(2)(4)</sup>		–	–	0.17	UI
TJ <sub>10.3125_QPLL</sub>	Total jitter <sup>(2)(4)</sup>	10.3125 Gb/s	–	–	0.28	UI
DJ <sub>10.3125_QPLL</sub>	Deterministic jitter <sup>(2)(4)</sup>		–	–	0.17	UI
TJ <sub>10.3125_CPLL</sub>	Total jitter <sup>(3)(4)</sup>	10.3125 Gb/s	–	–	0.33	UI
DJ <sub>10.3125_CPLL</sub>	Deterministic jitter <sup>(3)(4)</sup>		–	–	0.17	UI
TJ <sub>9.953</sub>	Total jitter <sup>(2)(4)</sup>	9.953 Gb/s	–	–	0.28	UI
DJ <sub>9.953</sub>	Deterministic jitter <sup>(2)(4)</sup>		–	–	0.17	UI
TJ <sub>9.8</sub>	Total jitter <sup>(2)(4)</sup>	9.8 Gb/s	–	–	0.28	UI
DJ <sub>9.8</sub>	Deterministic jitter <sup>(2)(4)</sup>		–	–	0.17	UI
TJ <sub>8.0_QPLL</sub>	Total jitter <sup>(2)(4)</sup>	8.0 Gb/s	–	–	0.28	UI
DJ <sub>8.0_QPLL</sub>	Deterministic jitter <sup>(2)(4)</sup>		–	–	0.17	UI

Table 82: XADC Specifications (Cont'd)

Parameter	Symbol	Comments/Conditions	Min	Typ	Max	Units
<b>XADC Reference<sup>(5)</sup></b>						
External Reference	V <sub>REFP</sub>	Externally supplied reference voltage	1.20	1.25	1.30	V
On-Chip Reference		Ground V <sub>REFP</sub> pin to AGND, T <sub>j</sub> = -40°C to 100°C	1.2375	1.25	1.2625	V

**Notes:**

- Offset and gain errors are removed by enabling the XADC automatic gain calibration feature. The values are specified for when this feature is enabled.
- Only specified for new BitGen option XADCEnhancedLinearity = ON.
- For a detailed description, see the ADC chapter in the *7 Series FPGAs and Zynq-7000 AP SoC XADC Dual 12-Bit 1 MSPS Analog-to-Digital Converter* ([UG480](#)).
- For a detailed description, see the Timing chapter in the *7 Series FPGAs and Zynq-7000 AP SoC XADC Dual 12-Bit 1 MSPS Analog-to-Digital Converter* ([UG480](#)).
- Any variation in the reference voltage from the nominal V<sub>REFP</sub> = 1.25V and V<sub>REFN</sub> = 0V will result in a deviation from the ideal transfer function. This also impacts the accuracy of the internal sensor measurements (i.e., temperature and power supply). However, for external ratio metric type applications allowing reference to vary by ±4% is permitted. On-chip reference variation is ±1%.

## Configuration Switching Characteristics

Table 83: Configuration Switching Characteristics

Symbol	Description	Virtex-7 T and XT Devices	Speed Grade			Units
			-3	-2/-2L/-2G	-1	
<b>Power-up Timing Characteristics</b>						
T <sub>PL</sub> <sup>(1)</sup>	Program latency		5	5	5	ms, Max
T <sub>POR</sub> <sup>(1)</sup>	Power-on reset (50ms ramp rate time)	10/50	10/50	10/50	ms, Min/Max	
	Power-on reset (1ms ramp rate time)	10/35	10/35	10/35	ms, Min/Max	
T <sub>PROGRAM</sub>	Program pulse width	250	250	250	ns, Min	
<b>CCLK Output (Master Mode)</b>						
T <sub>ICCK</sub>	Master CCLK output delay	150	150	150	ns, Min	
T <sub>MCCKL</sub>	Master CCLK clock Low time duty cycle	40/60	40/60	40/60	%, Min/Max	
T <sub>MCCKH</sub>	Master CCLK clock High time duty cycle	40/60	40/60	40/60	%, Min/Max	
F <sub>MCCK</sub>	Master CCLK frequency	100	100	100	MHz, Max	
	Master CCLK frequency for AES encrypted x16	50	50	50	MHz, Max	
F <sub>MCCK_START</sub>	Master CCLK frequency at start of configuration	3	3	3	MHz, Typ	
F <sub>MCCKTOL</sub>	Frequency tolerance, master mode with respect to nominal CCLK.	±50	±50	±50	%, Max	
<b>CCLK Input (Slave Modes)</b>						
T <sub>SCCKL</sub>	Slave CCLK clock minimum Low time	2.5	2.5	2.5	ns, Min	
T <sub>SCCKH</sub>	Slave CCLK clock minimum High time	2.5	2.5	2.5	ns, Min	
F <sub>SCCK</sub>	Slave CCLK frequency	100	100	100	MHz, Max	
<b>EMCCLK Input (Master Mode)</b>						
T <sub>EMCCKL</sub>	External master CCLK Low time	2.5	2.5	2.5	ns, Min	
T <sub>EMCCKH</sub>	External master CCLK High time	2.5	2.5	2.5	ns, Min	
F <sub>EMCCK</sub>	External master CCLK frequency	100	100	100	MHz, Max	
<b>Internal Configuration Access Port</b>						
F <sub>ICAPCK</sub>	Internal configuration access port (ICAPE2)	100.00	100.00	100.00	MHz, Max	

Date	Version	Description
08/03/2012	1.5	<p>Updated the descriptions, changed <math>V_{IN}</math> and <a href="#">Note 2</a> and added <a href="#">Note 4</a> in <a href="#">Table 1</a>. In <a href="#">Table 2</a>, changed descriptions and notes, removed Note 7, changed GTX transceiver parameters and values and added <a href="#">Note 12</a> and <a href="#">Note 13</a>. Updated parameters in <a href="#">Table 3</a>. Added <a href="#">Table 4</a> and <a href="#">Table 5</a>. Updated the values for in <a href="#">Table 7</a>. Updated LVCMS12 and the SSTLs in <a href="#">Table 9</a>. Updated many of the specifications in <a href="#">Table 10</a> and <a href="#">Table 11</a>.</p> <p>Updated the <a href="#">AC Switching Characteristics</a> section, based upon <a href="#">Table 14</a>, for the ISE 14.2 speed specifications throughout the document with appropriate changes to <a href="#">Table 15</a> and <a href="#">Table 16</a> including production release of the XC7VX485T in the -2 and -1 speed designations.</p> <p>Added notes and specifications to <a href="#">Table 18</a>. Updated the <a href="#">IOB Pad Input/Output/3-State</a> discussion and changed <a href="#">Table 21</a> by adding <math>T_{IOIBUFDISABLE}</math>.</p> <p>Removed many of the combinatorial delay specifications and <math>T_{CINCK}/T_{CKCIN}</math> from <a href="#">Table 28</a>.</p> <p>Rearranged <a href="#">Table 51</a> including moving some parameters to <a href="#">Table 1</a>. Added <a href="#">Table 56</a>. Updated <a href="#">Table 57</a>. In <a href="#">Table 59</a>, updated SJ Jitter Tolerance with Stressed Eye section, <a href="#">page 48</a> and <a href="#">Note 8</a>. Added <a href="#">Note 1</a>, <a href="#">Note 2</a>, and <a href="#">Note 3</a> to <a href="#">Table 62</a>. Added <a href="#">Note 1</a> and <a href="#">Note 2</a> to <a href="#">Table 63</a>, and line rate ranges. Updated <a href="#">Table 64</a> including adding <a href="#">Note 1</a>. Updated <a href="#">Table 65</a> including adding <a href="#">Note 1</a>. In <a href="#">Table 82</a> updated <a href="#">Note 1</a> and added <a href="#">Note 4</a>. In <a href="#">Table 83</a>, updated <math>T_{POR}</math> and <math>F_{EMCCK}</math>.</p>
09/20/2012	1.6	Removed the XC7V1500T device from data sheet. In <a href="#">Table 2</a> , revised $V_{CCINT}$ and $V_{CCBRAM}$ and added <a href="#">Note 3</a> . Updated some of the values in <a href="#">Table 7</a> . Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7V585T in the -2 and -1 speed designations. Added values for the XC7V585T in <a href="#">Table 50</a> . Updated <a href="#">Note 2</a> in <a href="#">Table 58</a> .
09/26/2012	1.7	Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7VX485T in the -3 speed designation.
10/19/2012	1.8	<p>Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7VX485T in the -2L (1.0V) speed designation.</p> <p>Removed -2L (0.9V) speed specifications from data sheet, this change includes edits to <math>V_{CCINT}</math> and <math>V_{CCBRAM}</math> in <a href="#">Table 2</a>, editing <a href="#">Note 1</a> and removing Note 2 in <a href="#">Table 53</a>. Also in <a href="#">Table 53</a>, updated the <math>F_{GTXMAX}</math>, <math>F_{GTXQRANGE1}</math>, and <math>F_{GQPLL RANGE1}</math> specification for -1 speed grade from 6.6 Gb/s to 8.0 Gb/s. Edited <a href="#">Note 4</a> in <a href="#">Table 57</a> and <a href="#">Note 3</a> in <a href="#">Table 72</a>.</p>
12/12/2012	1.9	<p>Updated the <a href="#">AC Switching Characteristics</a> section, based upon <a href="#">Table 14</a>, for the ISE 14.3 speed specifications throughout the document. Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7V585T in the -3 and -2L(1.0V) speed designations. Updated the notes in <a href="#">Table 50</a>.</p> <p>Updated <a href="#">GTH Transceiver Specifications</a> including removal of GTH Transceiver DC Characteristics section (use the XPE (download at <a href="http://www.xilinx.com/power">http://www.xilinx.com/power</a>)). Updated <a href="#">Table 68</a> and added <a href="#">Table 71</a>, <a href="#">Table 73</a>, and <a href="#">Table 74</a>. Removed Note 4 from <a href="#">Table 82</a>.</p>
12/24/2012	1.10	<p>Updated the <a href="#">AC Switching Characteristics</a> section, based upon <a href="#">Table 14</a>, for the ISE 14.4 and Vivado 2012.4 speed specifications throughout the document. Revised the XC7V2000T in the -1 and -2 speed designations <a href="#">Table 15</a> to preliminary.</p> <p>Added the <a href="#">GTH Transceiver Protocol Jitter Characteristics</a> section. Updated <math>T_{TCKTDO}</math> and added <a href="#">Internal Configuration Access Port</a> section to <a href="#">Table 83</a>.</p>
01/31/2013	1.11	<p>Added <a href="#">Note 2</a> to <a href="#">Table 2</a>. Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7V2000T in the -1 and -2 speed specifications. Updated <a href="#">Note 1</a> in <a href="#">Table 35</a>. Updated the notes in <a href="#">Table 37</a>, <a href="#">Table 40</a> through <a href="#">Table 43</a>, <a href="#">Table 46</a>, and <a href="#">Table 47</a>. In <a href="#">Table 66</a>, updated <math>D_{VPPIN}</math>. In <a href="#">Table 67</a>, updated <math>V_{IDIFF}</math>. Removed <math>T_{LOCK}</math> and <math>T_{PHASE}</math> from <a href="#">Table 70</a>. Updated <math>T_{DLOCK}</math> in <a href="#">Table 71</a>.</p>
03/07/2013	1.12	<p>Updated the <a href="#">AC Switching Characteristics</a> section, based upon <a href="#">Table 14</a>, for the ISE 14.5 and Vivado 2013.1 speed specifications throughout the document. Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7VX690T.</p> <p>Revised <math>D_{VPPOUT}</math> in <a href="#">Table 66</a>. Updated values in <a href="#">Table 67</a> and <a href="#">Table 74</a>. Removed Note 1 from <a href="#">Table 68</a>. Updated <math>MMCM\_F_{PFDMAX}</math> in <a href="#">Table 38</a> and <math>PLL\_F_{PFDMAX}</math> in <a href="#">Table 39</a>. Added skew values to <a href="#">Table 50</a>.</p>